

## **Search Notes**



**Application/Control No.**

10/711,991

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**Examiner**

Trinh T. Nguyen

**Applicant(s)/Patent under  
Reexamination**

SHARPLES ET AL.

## Art Unit

3644

**SEARCHED**

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner